

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/693,872	HAYAMA, AKIRA	
		Examiner	Art Unit	Page 1 of 1
		Gabriel D. Olander	2879	

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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B	US-			
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E	US-			
F	US-			
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H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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